

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/734,440	SAMPATH ET AL.	
Examiner	Art Unit	
SHICK C. HOM	2416	

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	SEARCHED				
Class	Subclass	Date	Examiner		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST (USPT, US-PGPUB) - See search history printout	4/2/2009	SH	
Inventor search - See search history printout	4/2/09	Sh	